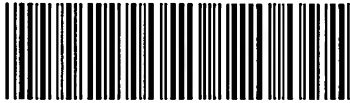


**Search Notes**

Application/Control No.

10/823,732

Examiner

Patricia T. Nguyen

Applicant(s)/Patent under  
Reexamination

BLECKER ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	253	4/28/2005	PN
	257		
	258		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
330	253	4/28/2005	PN
	257		
	258		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR